

SIDC46D170H

Fast switching diode chip in EMCON 3-Technology

FEATURES:

- 1700V EMCON 3 technology 200 µm chip
- soft, fast switching
- low reverse recovery charge
- small temperature coefficient

This chip is used for:

EUPEC power modules



Applications:

• resonant applications, drives

Chip Type	V _R	IF	Die Size	Package	Ordering Code
SIDC46D170H	1700V	75A	6.8 x 6.8 mm ²	sawn on foil	Q67050-A4175- A001

MECHANICAL PARAMETER:

Raster size	6.8 x 6.8				
Area total / active	46.24 / 34.04	mm ²			
Anode pad size	4.78 x 4.78				
Thickness	200	μm			
Wafer size	150	mm			
Flat position	180	deg			
Max. possible chips per wafer	304 pcs				
Passivation frontside	Photoimide				
Anode metallization	3200 nm Al Si Cu				
Cathode metallization	Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500µm				
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				

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Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V _{RRM}		1700	V
Continuous forward current limited by T _{jmax}	I _F		75	
Single pulse forward current (depending on wire bond configuration)	I _{FSM}	t _P = 10 ms sinusoidal	430	A
Maximum repetitive forward current limited by T _{jmax}	I _{FRM}		150	
Operating junction and storage temperature	$T_{\rm j}$, $T_{ m stg}$		-55+150	°C

Static Electrical Characteristics (tested on chip), T_j =25 °C, unless otherwise specified

Parameter	Symbol	Cond	Value			Unit	
	Symbol	Conditions		min.	Тур.	max.	onne
Reverse leakage current	I _R	V _R =1700V	<i>T_j</i> =25 ° <i>C</i>			27	μA
Cathode-Anode breakdown Voltage	V _{Br}	I _R =0.25mA	<i>T_j</i> =25°C	1700			V
Forward voltage drop	V _F	I _F =75A	<i>T_j</i> =25°C		1.8		V

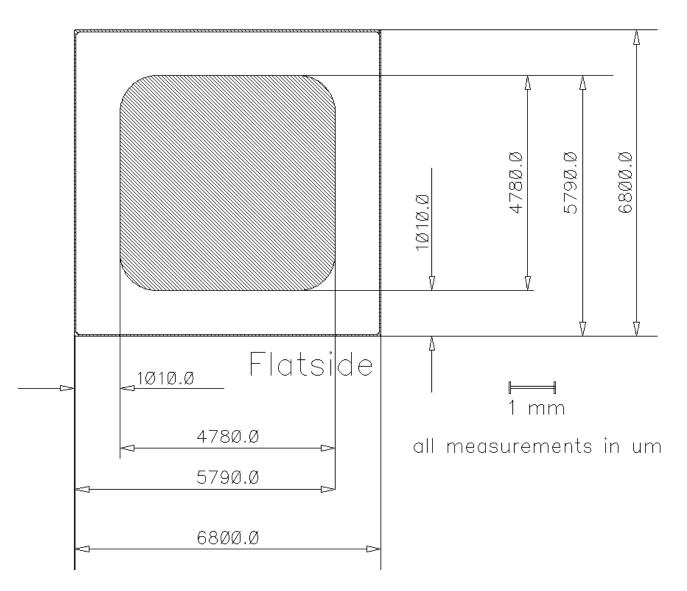
Dynamic Electrical Characteristics, at T_j = 25 °C, unless otherwise specified, tested at component

Parameter	Symbol	Conditions		Value			Unit
Falameter	Symbol			min.	Тур.	max.	
Peak recovery current	I _{RRM1}	<i>I_F</i> =75A di/dt=920A/ m s	$T_j = 25 \ ^{\circ}C$		93		А
	I _{RRM2}	$V_R = 900V$	$T_{j} = 125 \ ^{\circ}C$		100		
Reverse recovery charge	Q _{rr1}	<i>I_F</i> =75A di/dt=920A/ m s	<i>T_j</i> =25 ° <i>C</i>		20.0		
	Q _{rr2}	$V_R = 900V$	<i>T_j</i> =125°C		31.7		μC
Reverse recovery energy	E _{rec 1}	I _F =75A	$T_{\rm j}=25^{\circ}C$		10.0		
	E _{rec2}	<i>di/dt=920A/m</i> s <i>V_R=900V</i>	<i>T_j</i> =125°C		18.3		mJ



CHIP DRAWING:

L447A1



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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the	INFINEON TECHNOLOGIES /	tbd
device data sheet	EUPEC	ibu

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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